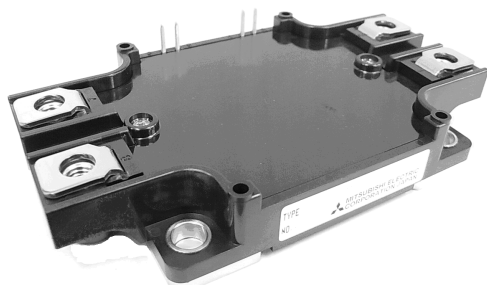


<IGBT Modules>

CM200EXS-34SA

HIGH POWER SWITCHING USE INSULATED TYPE



Brake-chopper

Collector current I_C	2 0 0 A
Collector-emitter voltage V_{CES}	1 7 0 0 V
Maximum junction temperature T_{jmax}	1 7 5 °C

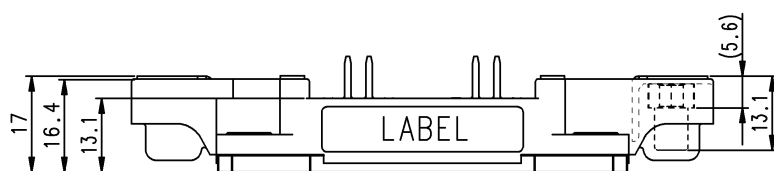
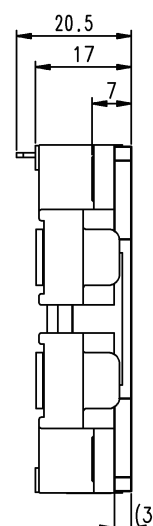
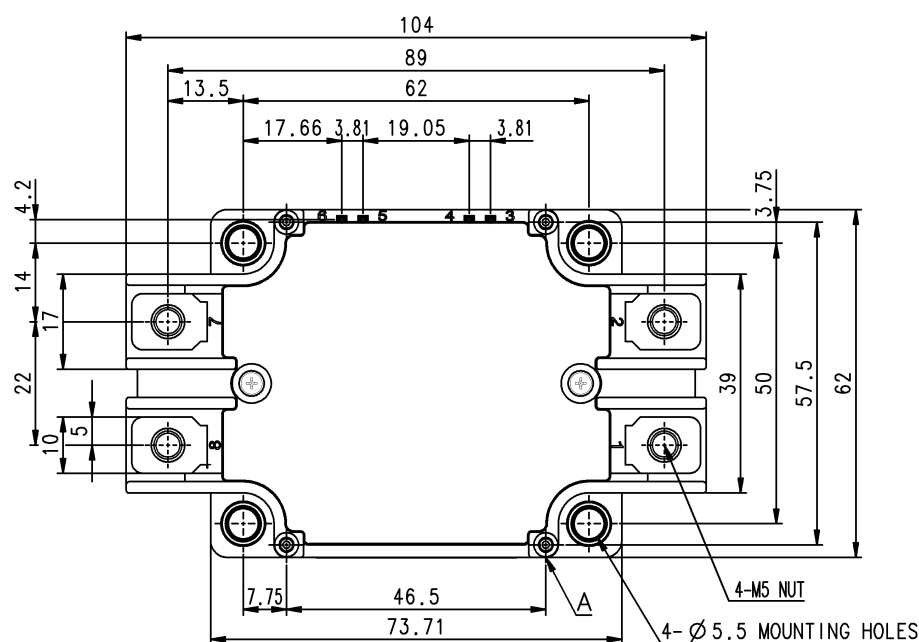
- Flat base Type
- Copper base plate (non-plating)
- Tin plating pin terminals
- RoHS Directive compliant
- Recognized under UL1557, File E323585

APPLICATION

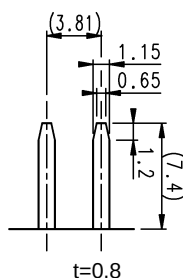
Brake

OUTLINE DRAWING & INTERNAL CONNECTION

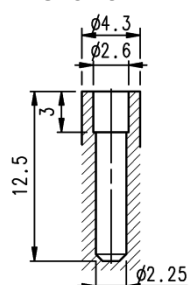
Dimension in mm



TERMINAL



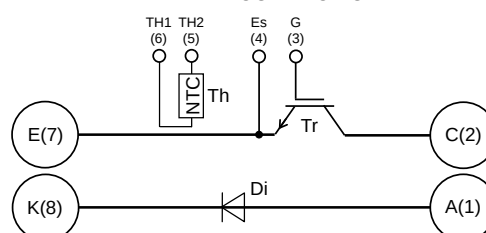
SECTION A



Division of Dimension	Tolerance
0.5 to 3	±0.2
over 3 to 6	±0.3
over 6 to 30	±0.5
over 30 to 120	±0.8
over 120 to 400	±1.2

The tolerance of size between terminals is assumed to be ± 0.4 .

INTERNAL CONNECTION



CM200EXS-34SA

HIGH POWER SWITCHING USE

INSULATED TYPE

MAXIMUM RATINGS ($T_J=25\text{ }^{\circ}\text{C}$, unless otherwise specified)

IGBT PART

Symbol	Item	Conditions	Rating	Unit
V_{CES}	Collector-emitter voltage	G-E short-circuited	1700	V
V_{GES}	Gate-emitter voltage	C-E short-circuited	± 20	V
I_C	Collector current	DC, $T_C=125\text{ }^{\circ}\text{C}$ (Note1, 3)	200	A
I_{CRM}		Pulse, Repetitive (Note2)	400	
P_{tot}	Total power dissipation	$T_C=25\text{ }^{\circ}\text{C}$ (Note1, 3)	2000	W

DIODE PART

Symbol	Item	Conditions	Rating	Unit
V_{RRM}	Repetitive peak reverse voltage	-	1700	V
I_F	Forward current	DC (Note1)	200	A
I_{FRM}		Pulse, Repetitive (Note2)	400	

MODULE

Symbol	Item	Conditions	Rating	Unit
V_{isol}	Isolation voltage	Terminals to base plate, RMS, f=60 Hz, AC 1 min	4000	V
T_{jmax}	Maximum junction temperature	Instantaneous event (overload)	175	$^{\circ}\text{C}$
T_{Cmax}	Maximum case temperature	(Note3)	125	
T_{jop}	Operating junction temperature	Continuous operation (under switching)	-40 ~ +150	$^{\circ}\text{C}$
T_{stg}	Storage temperature	-	-40 ~ +125	

ELECTRICAL CHARACTERISTICS ($T_J=25\text{ }^{\circ}\text{C}$, unless otherwise specified)

IGBT PART

Symbol	Item	Conditions		Limits			Unit
				Min.	Typ.	Max.	
I _{CES}	Collector-emitter cut-off current	V _{CE} =V _{CES} , G-E short-circuited		-	-	1.0	mA
I _{GES}	Gate-emitter leakage current	V _{GE} =V _{GES} , C-E short-circuited		-	-	0.5	μA
V _{GE(th)}	Gate-emitter threshold voltage	I _C =20 mA, V _{CE} =10 V		5.4	6.0	6.6	V
V _{Cesat} (Terminal)	Collector-emitter saturation voltage	I _C =200 A, V _{GE} =15 V, Refer to the figure of test circuit. (Note5)	T _J =25 °C	-	2.00	2.50	V
			T _J =125 °C	-	2.20	-	
			T _J =150 °C	-	2.25	-	
V _{Cesat} (Chip)		I _C =200 A, V _{GE} =15 V, (Note5)	T _J =25 °C	-	1.90	2.40	V
			T _J =125 °C	-	2.10	-	
			T _J =150 °C	-	2.15	-	
C _{ies}	Input capacitance	V _{CE} =10 V, G-E short-circuited		-	-	53	nF
C _{oes}	Output capacitance			-	-	4.3	
C _{res}	Reverse transfer capacitance			-	-	0.97	
Q _G	Gate charge	V _{CC} =1000 V, I _C =200 A, V _{GE} =15 V		-	1100	-	nC
t _{d(on)}	Turn-on delay time	V _{CC} =1000 V, I _C =200 A, V _{GE} =±15 V, R _G =0 Ω, Inductive load		-	-	400	ns
t _r	Rise time			-	-	100	
t _{d(off)}	Turn-off delay time			-	-	700	
t _f	Fall time			-	-	600	
E _{on}	Turn-on switching energy per pulse	V _{CC} =1000 V, I _C =I _E =200 A,		-	28	-	mJ
E _{off}	Turn-off switching energy per pulse	V _{GE} =±15 V, R _G =0 Ω, T _J =150 °C,		-	52	-	
R _{CC'+EE'}	Internal lead resistance	Main terminals-chip, per switch, T _C =25 °C (Note3)		-	-	2.0	mΩ
r _g	Internal gate resistance	-		-	2.5	-	Ω

CM200EXS-34SA

HIGH POWER SWITCHING USE

INSULATED TYPE

ELECTRICAL CHARACTERISTICS (cont.; $T_J=25\text{ }^{\circ}\text{C}$, unless otherwise specified)

DIODE PART

Symbol	Item	Conditions		Limits			Unit
				Min.	Typ.	Max.	
I _{RRM}	Reverse current	V _R =V _{RRM}		-	-	1.0	mA
V _F (Terminal)	Emitter-collector voltage	I _F =200 A, Refer to the figure of test circuit. (Note5)	T _J =25 °C	-	4.1	5.3	V
			T _J =125 °C	-	2.9	-	
			T _J =150 °C	-	2.7	-	
V _F (Chip)		I _F =200 A, (Note5)	T _J =25 °C	-	4.0	5.2	V
			T _J =125 °C	-	2.8	-	
			T _J =150 °C	-	2.6	-	
t _{rr}	Reverse recovery time	V _{CC} =1000 V, I _F =200 A, V _{GE} =±15 V, R _G =0 Ω, Inductive load		-	-	300	ns
Q _{rr}	Reverse recovery charge			-	8.0	-	μC
E _{rr}	Reverse recovery energy per pulse	V _{CC} =1000 V, I _F =200 A, V _{GE} =±15 V, R _G =0 Ω, T _J =150 °C, Inductive load		-	42	-	mJ

NTC THERMISTOR PART

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
R_{25}	Zero-power resistance	$T_C=25\text{ }^{\circ}\text{C}$ (Note3)	4.85	5.00	5.15	k Ω
$\Delta R/R$	Deviation of resistance	$R_{100}=493\text{ }\Omega$, $T_C=100\text{ }^{\circ}\text{C}$ (Note3)	-7.3	-	+7.8	%
$B_{(25/50)}$	B-constant	Approximate by equation (Note5)	-	3375	-	K
P_{25}	Power dissipation	$T_C=25\text{ }^{\circ}\text{C}$ (Note3)	-	-	10	mW

THERMAL RESISTANCE CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
$R_{th(j-c)Q}$	Thermal resistance	Junction to case, per IGBT (Note3)	-	-	0.075	K/W
$R_{th(j-c)D}$		Junction to case, per DIODE (Note3)	-	-	0.12	
$R_{th(c-s)}$	Contact thermal resistance	Case to heat sink, per 1 module, Thermal grease applied (Note3, 6)	-	25	-	K/kW

MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
M_t	Mounting torque	Main terminals M 5 screw	2.5	3.0	3.5	N·m
M_s		Mounting to heat sink M 5 screw	2.5	3.0	3.5	
d_s	Creepage distance	Terminal to terminal	20.6	-	-	mm
		Terminal to base plate	17	-	-	
d_a	Clearance distance	Terminal to terminal	12	-	-	mm
		Terminal to base plate	10.6	-	-	
m	mass	-	-	210	-	g
e_c	Flatness of base plate	On the centerline X, Y (Note7)	-100	-	+100	μm

CM200EXS-34SA

HIGH POWER SWITCHING USE
INSULATED TYPE

This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU.

Note1. Junction temperature (T_j) should not increase beyond T_{jmax} rating.

2. Pulse width and repetition rate should be such that the device junction temperature (T_j) dose not exceed T_{jmax} rating.

3. Case temperature (T_c) and heat sink temperature (T_s) are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.

4. Pulse width and repetition rate should be such as to cause negligible temperature rise.

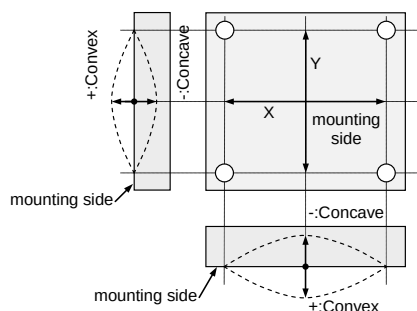
$$5. B_{(25/50)} = \ln\left(\frac{R_{25}}{R_{50}}\right) / \left(\frac{1}{T_{25}} - \frac{1}{T_{50}}\right)$$

R_{25} : resistance at absolute temperature T_{25} [K]; $T_{25}=25\text{ }^{\circ}\text{C}+273.15=298.15$ [K]

R_{50} : resistance at absolute temperature T_{50} [K]; $T_{50}=50\text{ }^{\circ}\text{C}+273.15=323.15$ [K]

6. Typical value is measured by using thermally conductive grease of $\lambda=0.9\text{ W/(m}\cdot\text{K)}$.

7. The base plate (mounting side) flatness measurement points (X, Y) are as follows of the following figure.



8. Use the following screws when mounting the printed circuit board (PCB) on the standoffs.

" $\phi 2.6 \times 10$ or $\phi 2.6 \times 12$, B1 tapping screw"

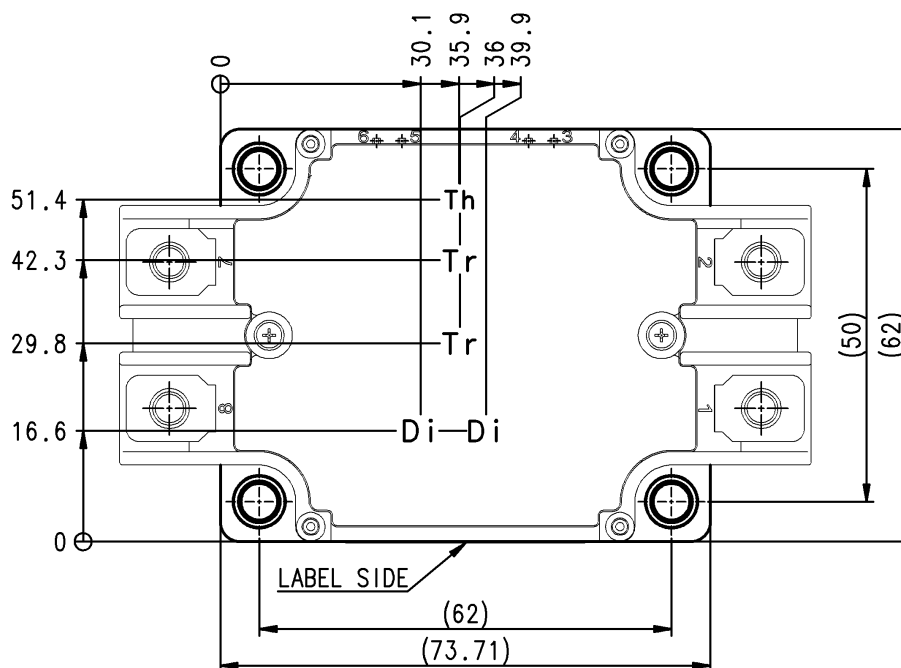
The length of the screw depends on the thickness (1.6~12.0) of the PCB.

RECOMMENDED OPERATING CONDITIONS

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
V_{CC}	(DC) Supply voltage	Applied across C-E/A-K	-	1000	1200	V
V_{GEon}	Gate (-emitter drive) voltage	Applied across G-Es	13.5	15.0	16.5	V
R_G	External gate resistance	-	0	-	38	Ω

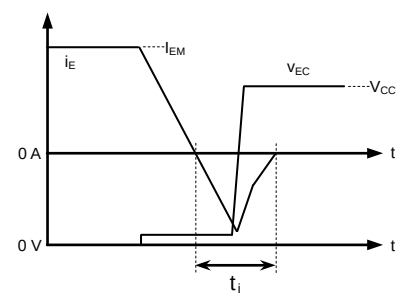
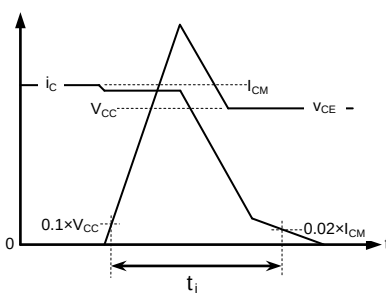
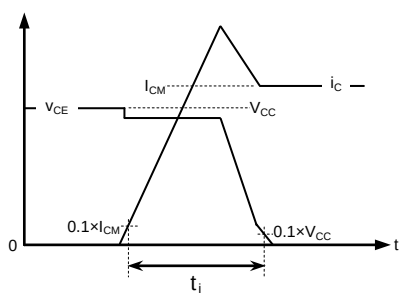
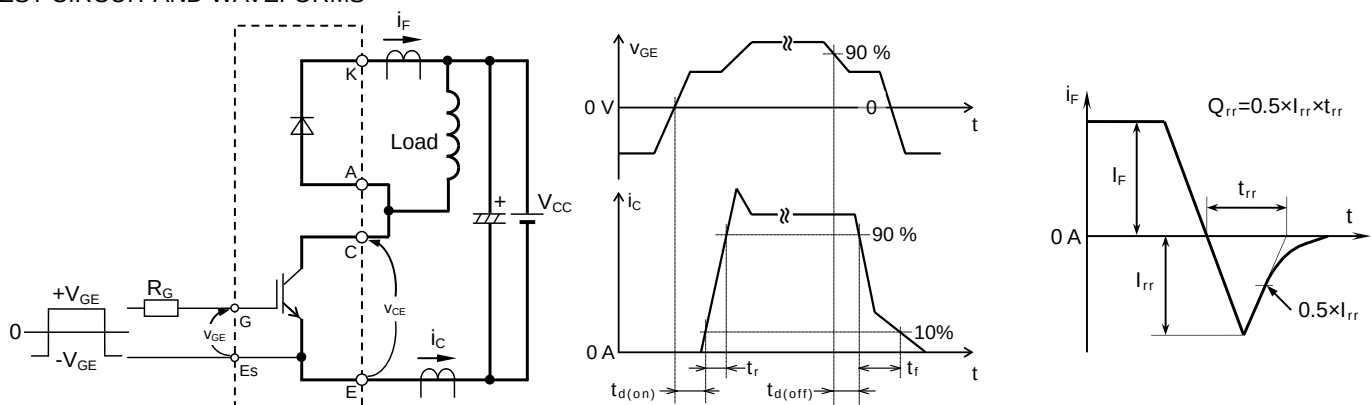
CHIP LOCATION (Top view)

Dimension in mm, tolerance: ± 1 mm



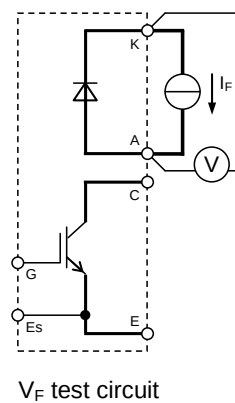
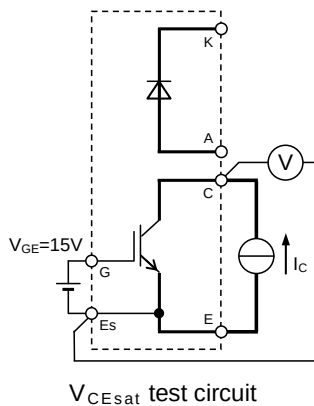
Tr: IGBT, Di: DIODE, Th: NTC thermistor

TEST CIRCUIT AND WAVEFORMS



Turn-on / Turn-off switching energy and Reverse recovery energy test waveforms (Integral time instruction drawing)

TEST CIRCUIT



CM200EXS-34SA

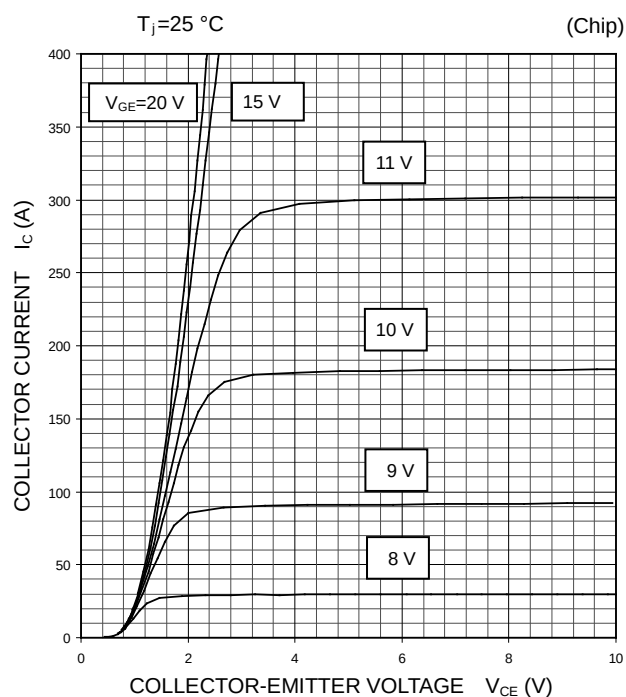
HIGH POWER SWITCHING USE

INSULATED TYPE

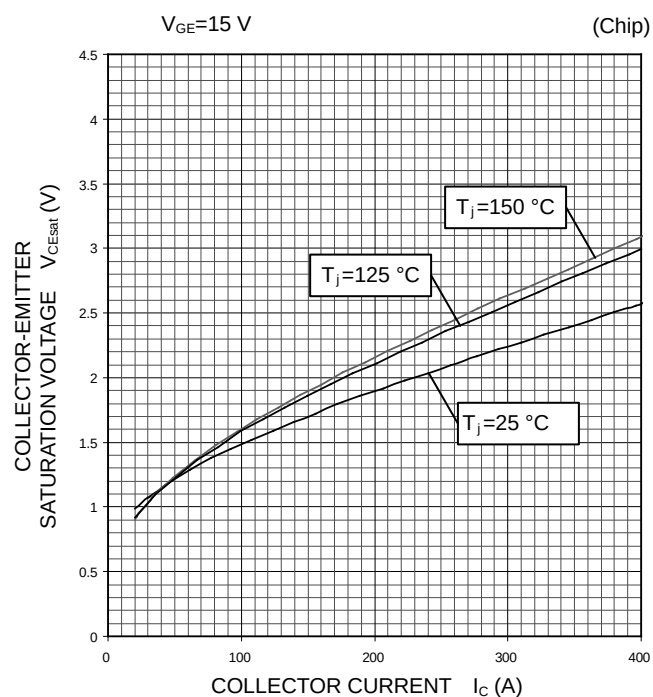
PERFORMANCE CURVES

IGBT / DIODE PART

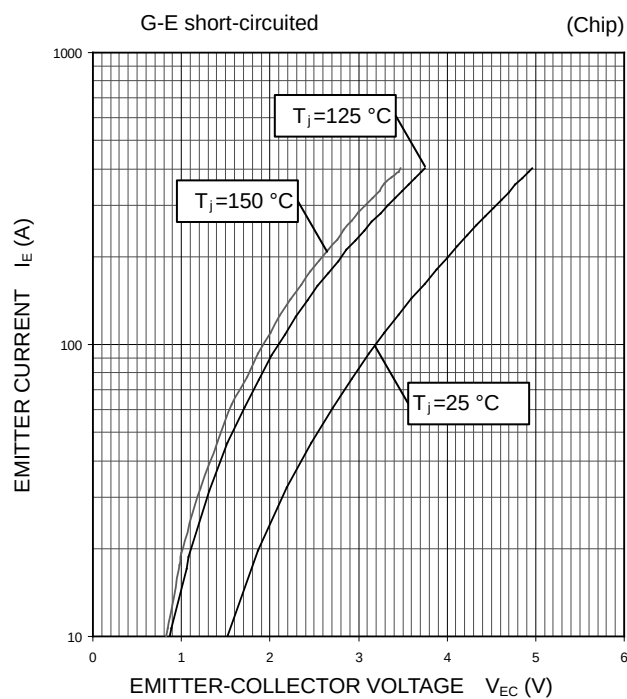
OUTPUT CHARACTERISTICS
(TYPICAL)



COLLECTOR-EMITTER SATURATION VOLTAGE
CHARACTERISTICS
(TYPICAL)



DIODE
FORWARD CHARACTERISTICS
(TYPICAL)



CM200EXS-34SA

HIGH POWER SWITCHING USE

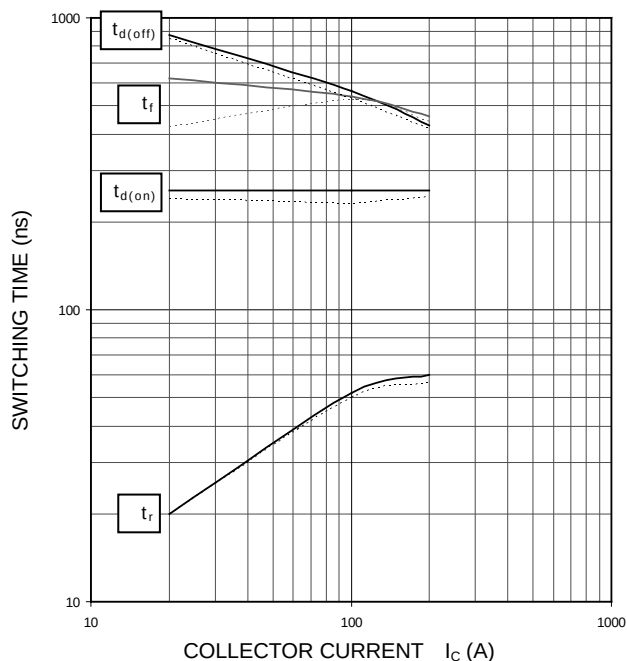
INSULATED TYPE

PERFORMANCE CURVES

IGBT / DIODE PART

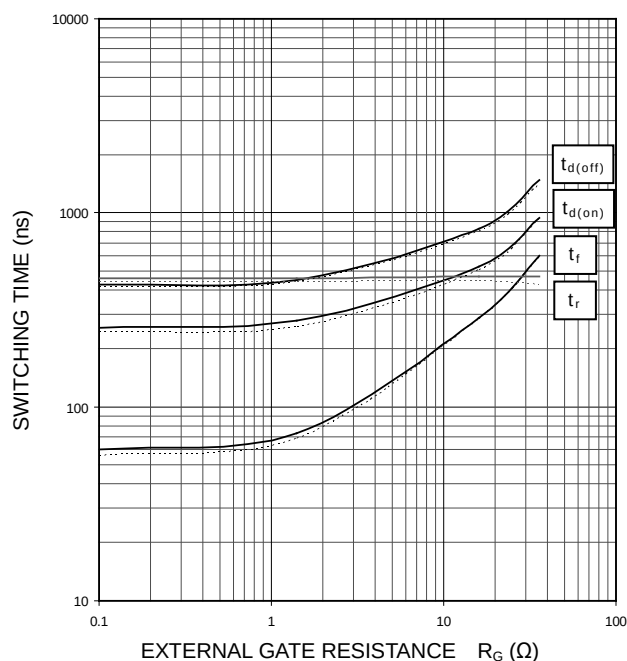
HALF-BRIDGE
SWITCHING CHARACTERISTICS
(TYPICAL)

 $V_{CC}=1000\text{ V}$, $V_{GE}=\pm 15\text{ V}$, $R_G=0\ \Omega$, INDUCTIVE LOAD

 —: $T_J=150\text{ }^\circ\text{C}$, - - - - -: $T_J=125\text{ }^\circ\text{C}$


HALF-BRIDGE
SWITCHING CHARACTERISTICS
(TYPICAL)

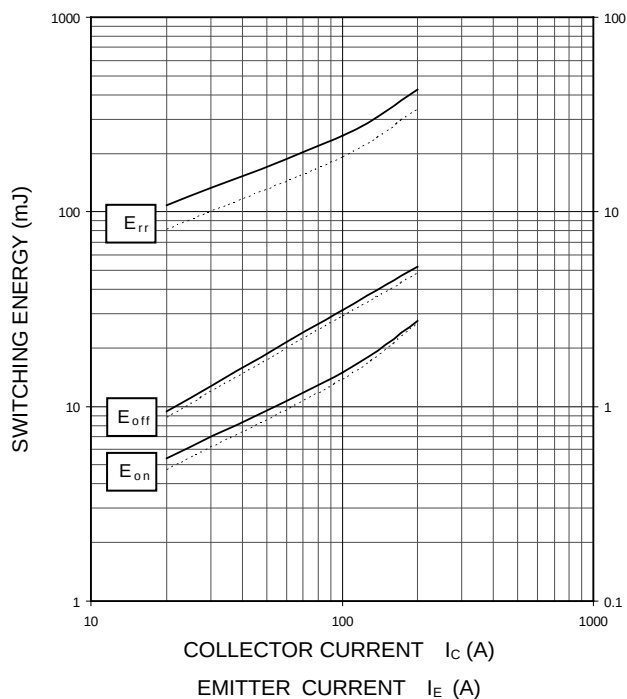
 $V_{CC}=1000\text{ V}$, $V_{GE}=\pm 15\text{ V}$, $I_C=200\text{ A}$, INDUCTIVE LOAD

 —: $T_J=150\text{ }^\circ\text{C}$, - - - - -: $T_J=125\text{ }^\circ\text{C}$


HALF-BRIDGE
SWITCHING CHARACTERISTICS
(TYPICAL)

 $V_{CC}=1000\text{ V}$, $V_{GE}=\pm 15\text{ V}$, $R_G=0\ \Omega$,

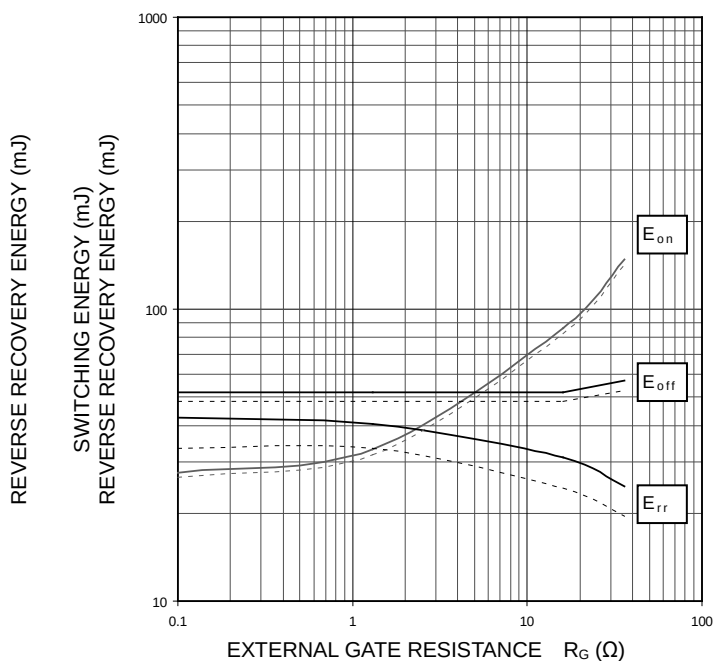
INDUCTIVE LOAD, PER PULSE

 —: $T_J=150\text{ }^\circ\text{C}$, - - - - -: $T_J=125\text{ }^\circ\text{C}$


HALF-BRIDGE
SWITCHING CHARACTERISTICS
(TYPICAL)

 $V_{CC}=1000\text{ V}$, $V_{GE}=\pm 15\text{ V}$, $I_C=200\text{ A}$,

INDUCTIVE LOAD, PER PULSE

 —: $T_J=150\text{ }^\circ\text{C}$, - - - - -: $T_J=125\text{ }^\circ\text{C}$


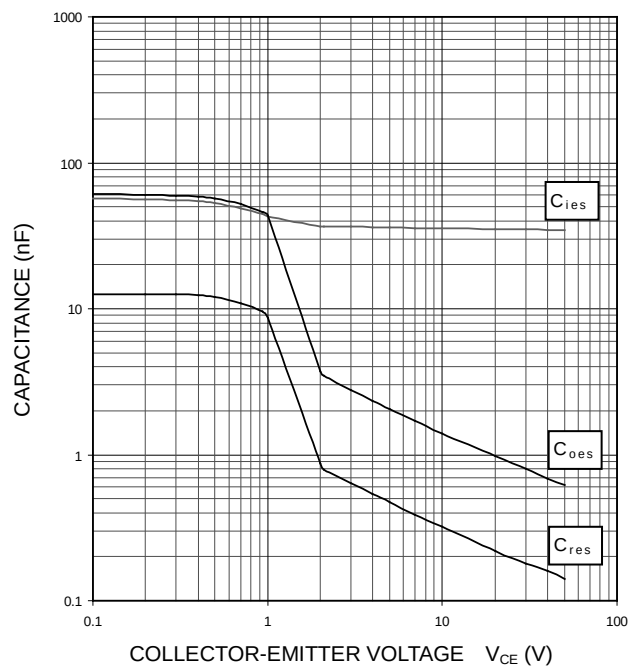
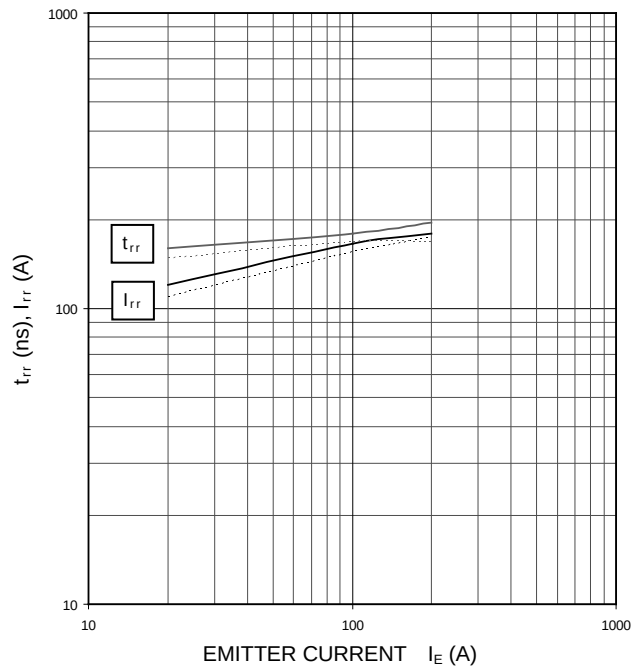
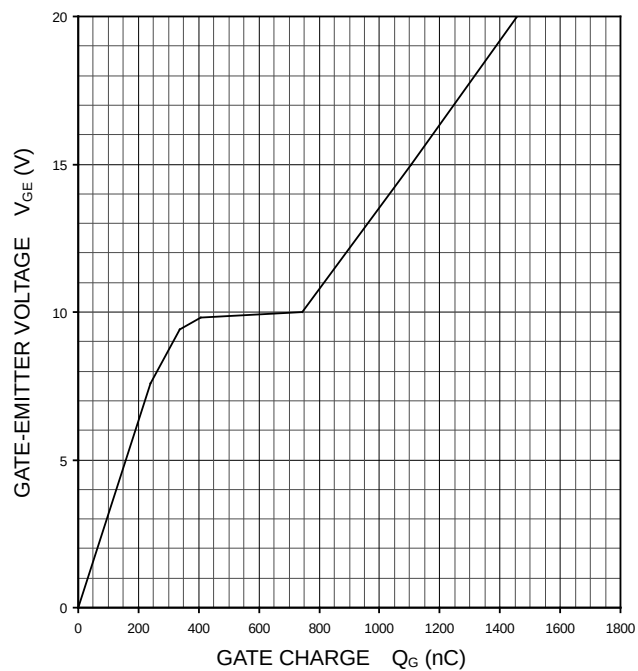
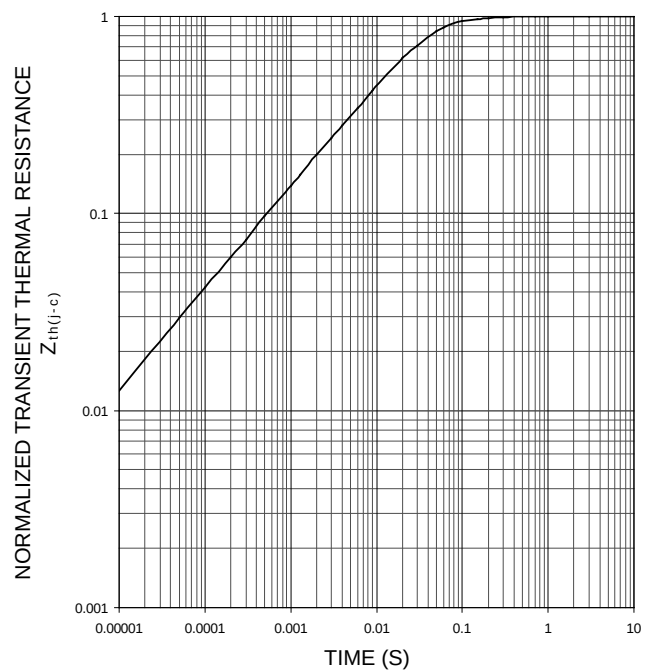
CM200EXS-34SA

HIGH POWER SWITCHING USE

INSULATED TYPE

PERFORMANCE CURVES

IGBT / DIODE PART

CAPACITANCE CHARACTERISTICS
(TYPICAL)G-E short-circuited, $T_j=25\text{ }^{\circ}\text{C}$ DIODE
REVERSE RECOVERY CHARACTERISTICS
(TYPICAL) $V_{CC}=1000\text{ V}$, $V_{GE}=\pm 15\text{ V}$, $R_G=0\text{ }\Omega$, INDUCTIVE LOAD—: $T_j=150\text{ }^{\circ}\text{C}$, - - - - : $T_j=125\text{ }^{\circ}\text{C}$ GATE CHARGE CHARACTERISTICS
(TYPICAL) $V_{CC}=1000\text{ V}$, $I_C=200\text{ A}$, $T_j=25\text{ }^{\circ}\text{C}$ TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS
(MAXIMUM)Single pulse, $T_C=25\text{ }^{\circ}\text{C}$ $R_{th(j-c)Q}=0.075\text{ K/W}$, $R_{th(j-c)D}=0.12\text{ K/W}$ 

CM200EXS-34SA

HIGH POWER SWITCHING USE

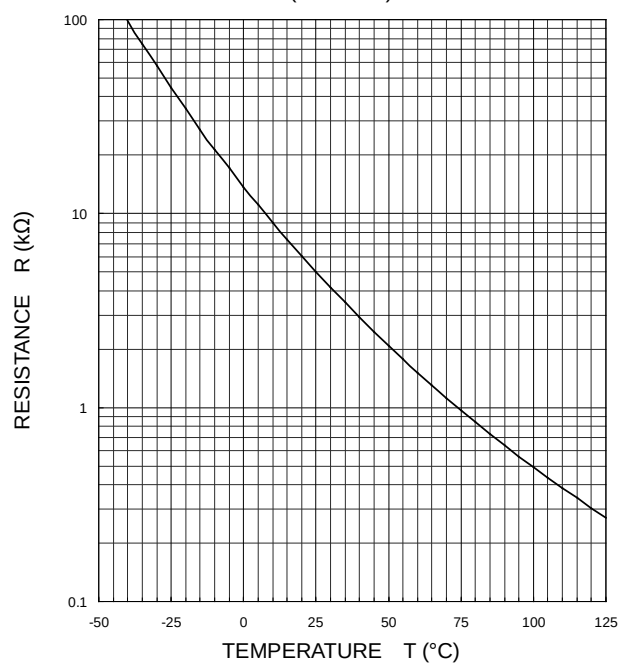
INSULATED TYPE

PERFORMANCE CURVES

NTC thermistor part

TEMPERATURE CHARACTERISTICS

(TYPICAL)



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